

November 2013

FQPF27N25

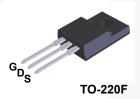
N-Channel QFET[®] MOSFET 250 V, 14 A, 110 m Ω

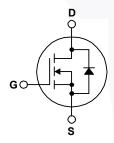
Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 14 A, 250 V, $R_{DS(on)}$ = 110 m Ω (Max.) @ V_{GS} = 10 V, I_D = 7 A
- Low Gate Charge (Typ. 50 nC)
- · Low Crss (Typ. 45 pF)
- · 100% Avalanche Tested





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQPF27N25	Unit	
V _{DSS}	Drain-Source Voltage		250	V	
I _D	Drain Current - Continuous (T _C = 25°C)		14	Α	
	- Continuous (T _C = 100°C)		8.9	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	56	Α	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	600	mJ	
I _{AR}	Avalanche Current	(Note 1)	14	Α	
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.5	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns	
P_D	Power Dissipation (T _C = 25°C)		55	W	
	- Derate above 25°C		0.44	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FQPF27N25	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.27	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQPF27N25	FQPF27N25	TO-220F	Tube	N/A	N/A	50 units

Electrical Characteristics

T_C = 25°C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	250			V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.29		V/°C
I _{DSS}	99	V _{DS} = 250 V, V _{GS} = 0 V			1	μΑ
Zero Gate Voltage Drain Current	V _{DS} = 200 V, T _C = 125°C			10	μΑ	
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics			•		
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 7.0 A		0.083	0.11	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 7.0 A		15		S
	ic Characteristics Input Capacitance			1900	2450	ηE
C _{iss}	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		360	470	pF pF
C _{rss}	Reverse Transfer Capacitance			45	60	рF
rss	reverse transfer Capacitatice			43	00	рі
Switch	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 125 \text{ V}, I_{D} = 27 \text{ A},$ $R_{G} = 25 \Omega$		32	75	ns
t _r	Turn-On Rise Time			270	550	ns
t _{d(off)}	Turn-Off Delay Time			80	170	ns
t _f	Turn-Off Fall Time	(Note 4)		120	250	ns
Qg	Total Gate Charge	V _{DS} = 200 V, I _D = 27 A,		50	65	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		12.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4)		26		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				14	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	Forward Current			56	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 14 A			1.5	V
			1			

Q_{rr}

 t_{rr}

- Notes: Notes: Notes: All the Notes: All the Notes: All the Notes: Pulse width limited by maximum junction temperature.
 2. L = 4.9 mH, I $_{AS}$ = 14 A, V $_{DD}$ = 50 V, R $_{G}$ = 25 Ω , starting T $_{J}$ = 25°C.
 3. I $_{SD}$ \leq 27 A, di/dt \leq 300 A/µs, V $_{DD}$ \leq BV $_{DSS}$, starting T $_{J}$ = 25°C.
 4. Essentially independent of operating temperature.

Reverse Recovery Time

Reverse Recovery Charge

ns

μС

220

1.8

 $V_{GS} = 0 \text{ V, } I_{S} = 27 \text{ A,}$

 $dI_F / dt = 100 A/\mu s$

Typical Characteristics

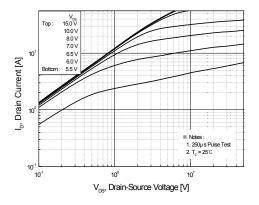
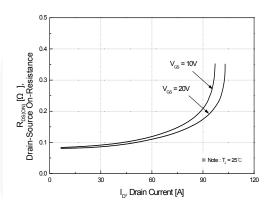


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



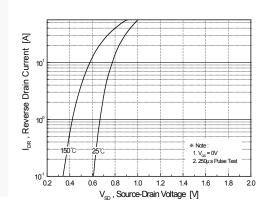
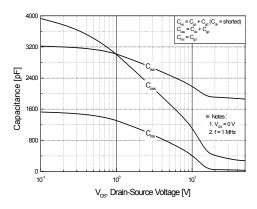


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature



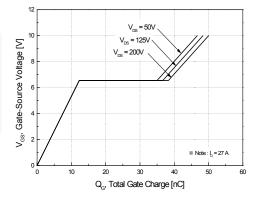


Figure 5. Capacitance Characteristics

Figure 6. Gate Charge Characteristics

Typical Characteristics (continued)

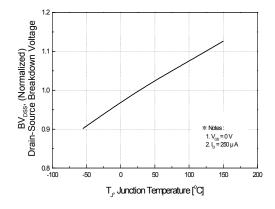
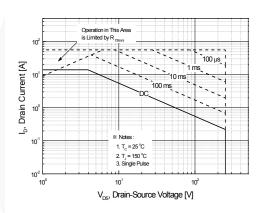


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



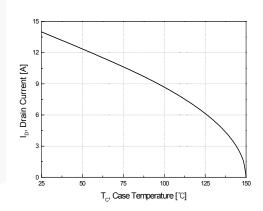


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

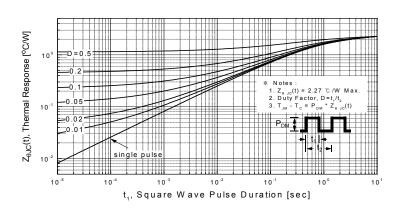


Figure 11. Transient Thermal Response Curve

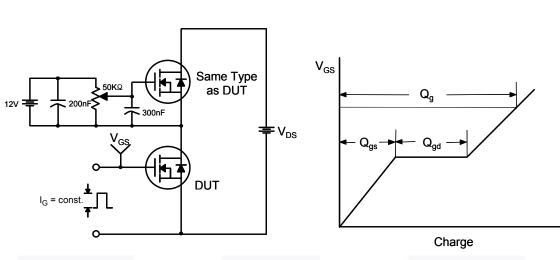


Figure 12. Gate Charge Test Circuit & Waveform

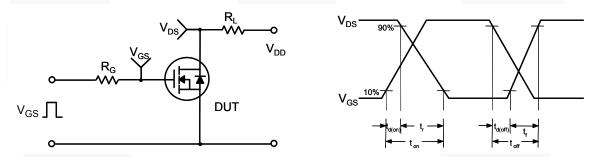


Figure 13. Resistive Switching Test Circuit & Waveforms

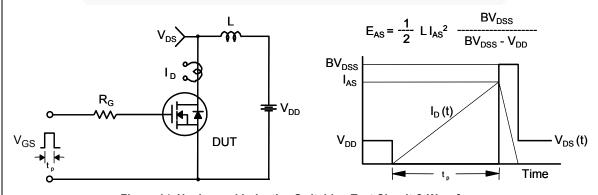
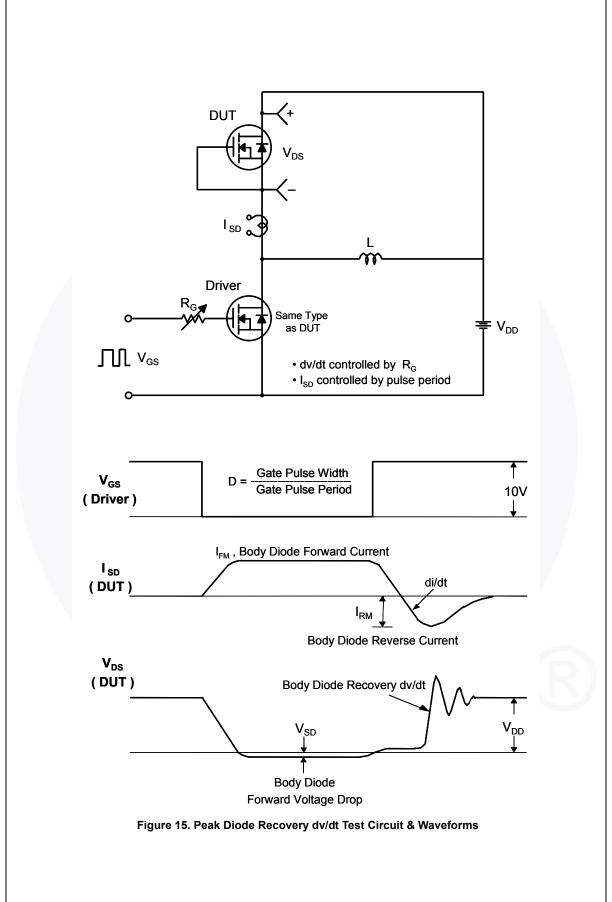


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

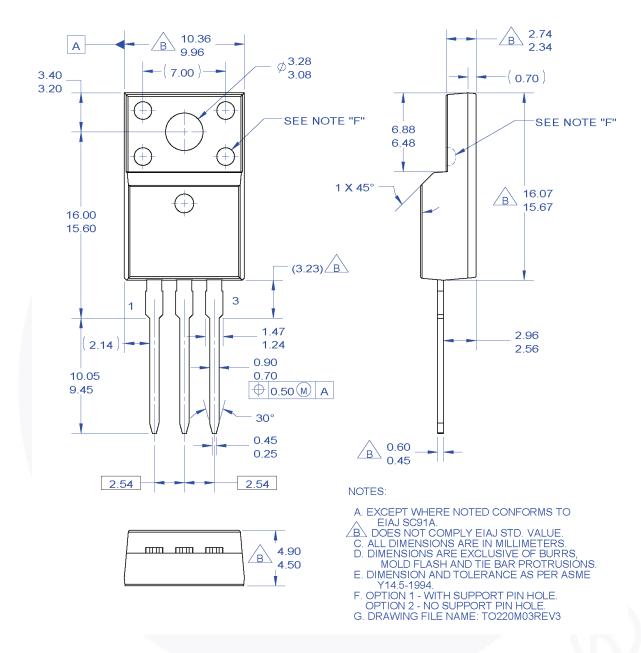


Figure 16. TO220, Molded, 3-Lead, Full Pack, EIAJ SC91, Straight Lead

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